

## ● General Description

The AGM18N10I combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ .

This device is ideal for load switch and battery protection applications.

## ● Features

- Advance high cell density Trench technology

- Low  $R_{DS(ON)}$  to minimize conductive loss

- Low Gate Charge for fast switching

- Low Thermal resistance

## ● Application

- MB/VGA Vcore

- SMPS 2<sup>nd</sup> Synchronous Rectifier

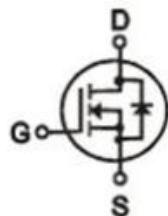
- POL application

- BLDC Motor driver

## Product Summary

BVDSS	RDS(ON)	ID
100V	16mΩ	40A

## TO-251 Pin Configuration



## Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
AGM18N10I	AGM18N10I	TO-251	330mm	16mm	2500

Table 1. Absolute Maximum Ratings (TA=25°C)

Symbol	Parameter	Value	Unit
VDS	Drain-Source Voltage (VGS=0V)	100	V
VGS	Gate-Source Voltage (VDS=0V)	±20	V
ID	Drain Current-Continuous(Tc=25°C) <b>(Note 1)</b>	40	A
	Drain Current-Continuous(Tc=100°C)	32	A
IDM (pulse)	Drain Current-Continuous@ Current-Pulsed <b>(Note 2)</b>	220	A
PD	Maximum Power Dissipation(Tc=25°C)	30	W
	Maximum Power Dissipation(Tc=100°C)	12	W
EAS	Avalanche energy <b>(Note 3)</b>	22	mJ
TJ,TSTG	Operating Junction and Storage Temperature Range	-55 To 150	°C

Table 2. Thermal Characteristic

Symbol	Parameter	Typ	Max	Unit
R <sub>θJA</sub>	Thermal Resistance Junction-ambient (Steady State) <sup>1</sup>	--	62	°C/W
R <sub>θJC</sub>	Thermal Resistance Junction-Case <sup>1</sup>	---	4.2	°C/W

**Table 3. Electrical Characteristics (TJ=25°C unless otherwise noted)**

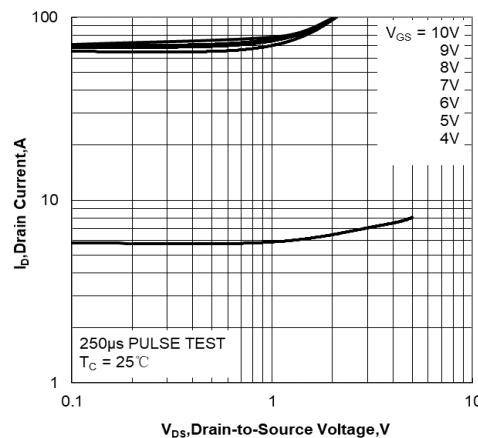
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>On/Off States</b>						
BVDSS	Drain-Source Breakdown Voltage	VGS=0V ID=250µA	100	--	--	V
IDSS	Zero Gate Voltage Drain Current	VDS=100V, VGS=0V	--	--	1	µA
IGSS	Gate-Body Leakage Current	VGS=±20V, VDS=0V	--	--	±100	nA
VGS(th)	Gate Threshold Voltage	VDS=VGS, ID=250µA	1.2	1.6	2.5	V
RDS(on)	Drain-Source On-State Resistance	VGS=10V, ID=12A	--	16	20	mΩ
		VGS=4.5V, ID=8A	--	20	25	mΩ
<b>Dynamic Characteristics</b>						
Ciss	Input Capacitance	VDS=50V, VGS=0V, F=1MHZ	--	800	--	pF
Coss	Output Capacitance		--	300	--	pF
Crss	Reverse Transfer Capacitance		--	22	--	pF
Rg	Gate resistance	VGS=0V, VDS=0V, f=1.0MHz	--	--	--	Ω
<b>Switching Times</b>						
td(on)	Turn-on Delay Time	VGS=10V, VDS=50V, ID=1A, RGEN=6Ω	--	15	--	nS
tr	Turn-on Rise Time		--	3.5	--	nS
td(off)	Turn-Off Delay Time		--	30	--	nS
tf	Turn-Off Fall Time		--	7.6	--	nS
Qg	Total Gate Charge	VGS=10V, VDS=50V, ID=8.5A	--	22.5	--	nC
Qgs	Gate-Source Charge		--	5.5	--	nC
Qgd	Gate-Drain Charge		--	15	--	nC
<b>Source-Drain Diode Characteristics</b>						
ISD	Source-Drain Current(Body Diode)		--	--	40	A
VSD	Forward on Voltage	VGS=0V, IS=12A	--	--	1.0	V
trr	Reverse Recovery Time	IF=12A, dl/dt=100A/µs, TJ=25°C	--	--	--	ns
Qrr	Reverse Recovery Charge		--	--	--	nc

Notes 1.The maximum current rating is package limited.

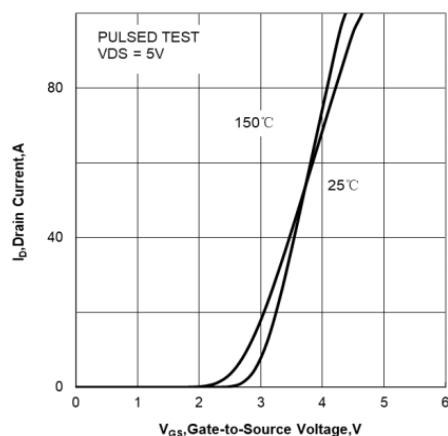
Notes 2.Repetitive Rating: Pulse width limited by maximum junction temperature

Notes 3.EAS condition: TJ=25°C

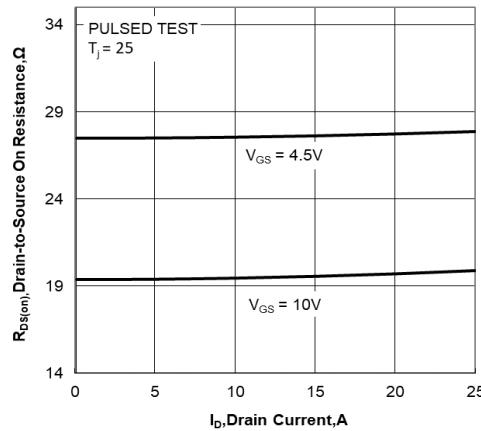
## Typical Performance Characteristics



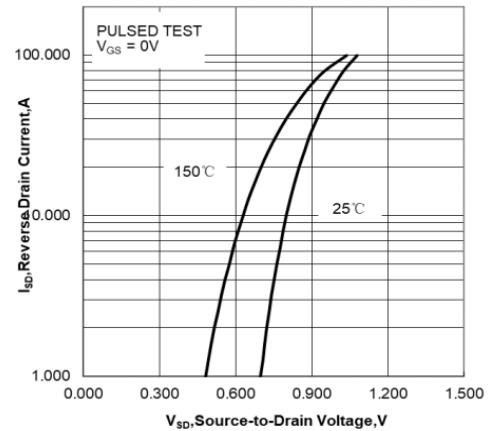
**Figure 1. Output Characteristics**



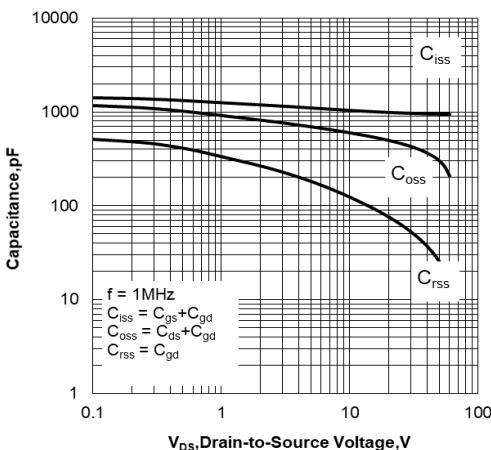
**Figure 2. Transfer Characteristics**



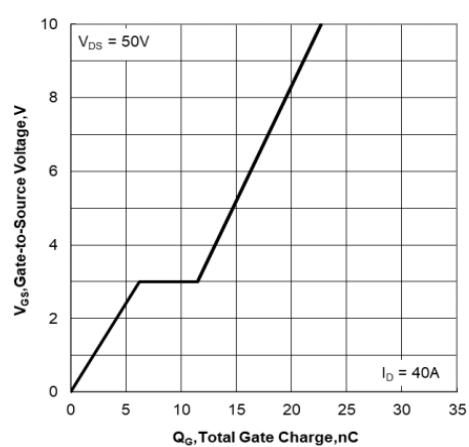
**Figure 3. Drain-to-Source On Resistance  
vs Drain Current**



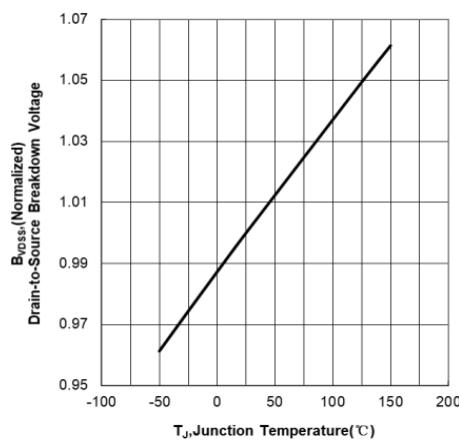
**Figure 4. Body Diode Forward Voltage  
vs Source Current and Temperature**



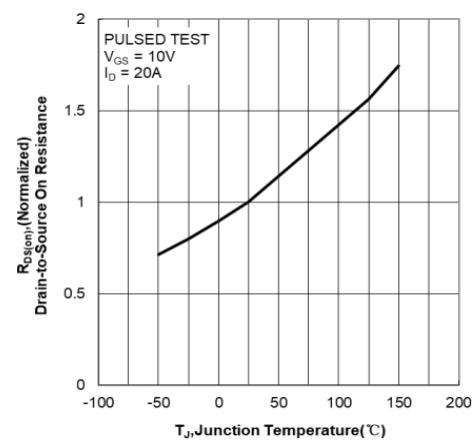
**Figure 5. Capacitance Characteristics**



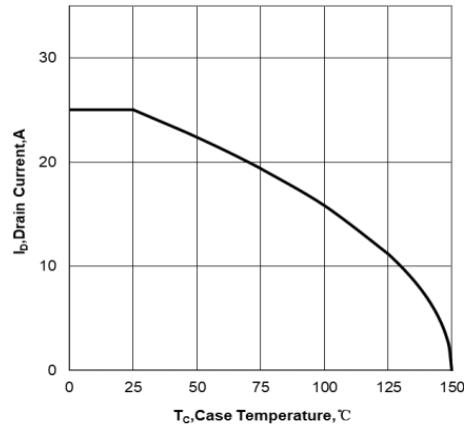
**Figure 6. Gate Charge Characteristics**



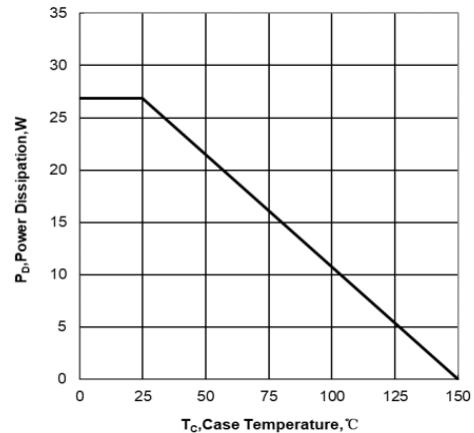
**Figure 7. Normalized Breakdown Voltage  
vs Junction Temperature**



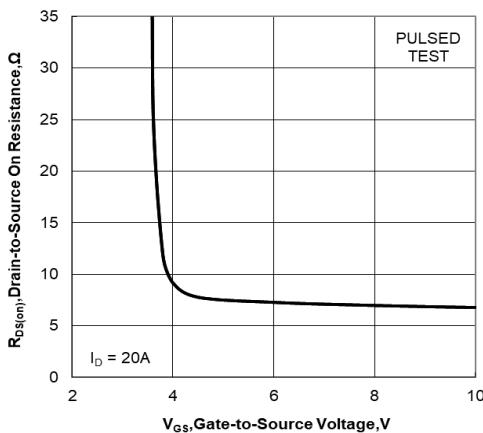
**Figure 8. Normalized On Resistance vs  
Junction Temperature**



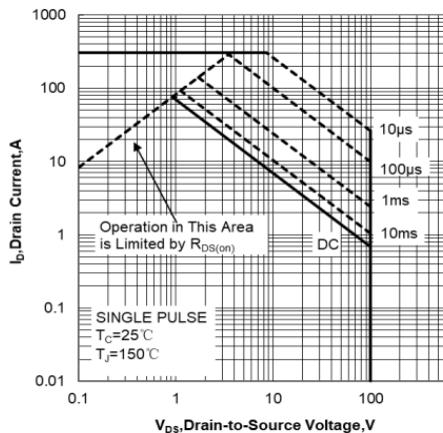
**Figure 9. Maximum Continuous Drain Current  
vs Case Temperature**



**Figure 10. Maximum Power Dissipation  
vs Case Temperature**



**Figure 11. Drain-to-Source On Resistance vs Gate**



**Figure 12. Maximum Safe Operating Area**

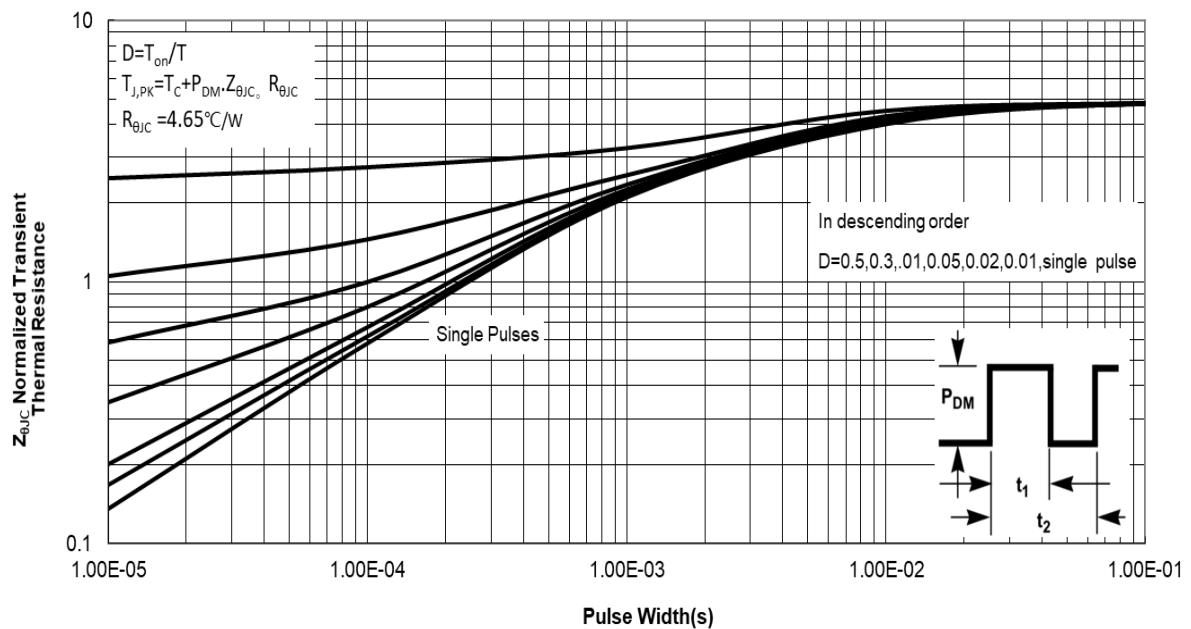
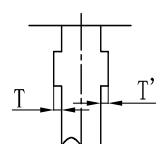
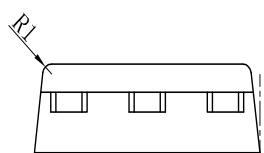
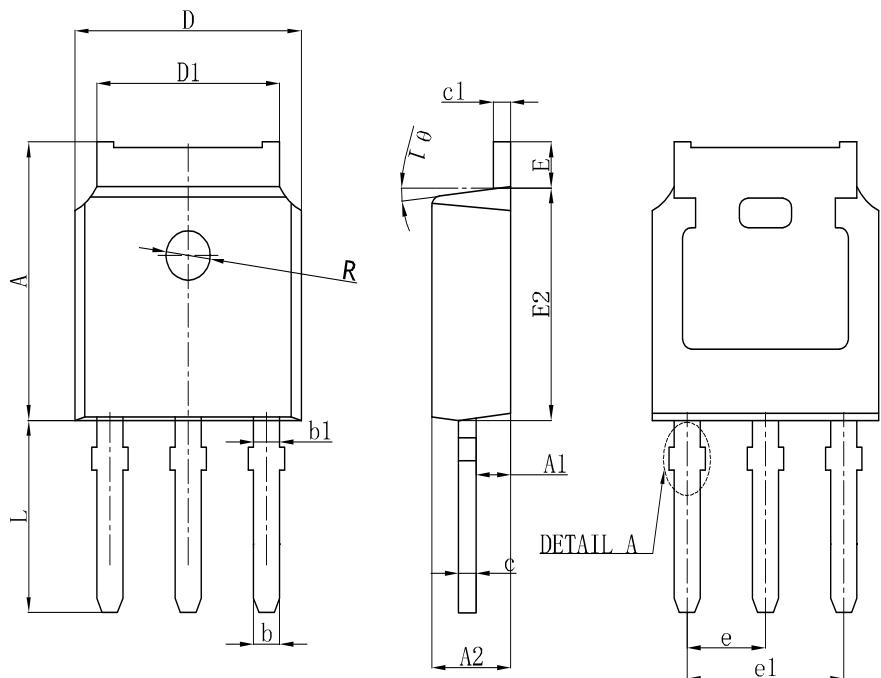


Figure 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

## TO-251 Package Outline Data



$0 \leq T, T' \leq 0.12$   
DETAIL A

SYMBOL	MILLIMETER		
	MIN	NOM	MAX
A	7.050	7.100	7.150
A1	0.960	1.010	1.060
A2	2.250	2.300	2.350
b	0.760REF.		
b1	1.000REF.		
c	0.508REF.		
c1	0.508REF.		
D	6.550	6.600	6.650
D1	5.220	5.320	5.420
E	0.950	1.000	1.050
E2	6.050	6.100	6.150
e	2.286BSC		
e1	4.572REF.		
L	4.800	5.000	5.200
$\theta_1$	7° REF.		
R	1.300REF.		
R1	0.250REF.		

**Disclaimer:**

The information provided in this document is believed to be accurate and reliable. however, Shenzhen Core Control Electronics Technology Co., Ltd. does not assume any responsibility for the following consequences. Do not consider the use of such information or use beyond its scope.

The information mentioned in this document may be changed at any time without notice.

The products and information provided in this document do not infringe patents. Shenzhen Core Control Electronics Technology Co., Ltd. assumes no responsibility for any infringement of any other rights of third parties. The result of using such products and information.

This document is the first version issued on May 10th, 2023. This document replaces all previously provided information.

 It is a registered trademark of Shenzhen Core Control Electronics Technology Co., Ltd.

Copyright © 2017 Shenzhen Core Control Electronics Technology Co., Ltd. all rights reserved.